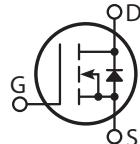
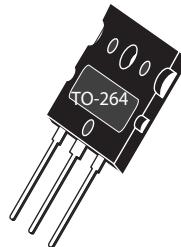


## Super Junction MOSFET

- Ultra Low  $R_{DS(ON)}$
- Low Miller Capacitance
- Ultra Low Gate Charge,  $Q_g$
- Avalanche Energy Rated
- Extreme  $dV/dt$  Rated
- Dual die (parallel)
- Popular T-MAX Package



Unless stated otherwise, Microsemi discrete MOSFETs contain a single MOSFET die. This device is made with two parallel MOSFET die. It is intended for switch-mode operation. It is not suitable for linear mode operation.

### MAXIMUM RATINGS

All Ratings per die:  $T_c = 25^\circ\text{C}$  unless otherwise specified.

Symbol	Parameter	APT94N60L2C3(G)	UNIT
$V_{DSS}$	Drain-Source Voltage	600	Volts
$I_D$	Continuous Drain Current @ $T_c = 25^\circ\text{C}$	94	Amps
$I_{DM}$	Pulsed Drain Current <sup>1</sup>	282	
$V_{GS}$	Gate-Source Voltage Continuous	$\pm 20$	Volts
$V_{GSM}$	Gate-Source Voltage Transient	$\pm 30$	
$P_D$	Total Power Dissipation @ $T_c = 25^\circ\text{C}$	833	Watts
	Linear Derating Factor	6.67	$\text{W}/^\circ\text{C}$
$T_J, T_{STG}$	Operating and Storage Junction Temperature Range	-55 to 150	$^\circ\text{C}$
$T_L$	Lead Temperature: 0.063" from Case for 10 Sec.	300	
$dV/dt$	Drain-Source Voltage slope ( $V_{DS} = 480\text{V}$ , $I_D = 94\text{A}$ , $T_J = 125^\circ\text{C}$ )	50	$\text{V}/\text{ns}$
$I_{AR}$	Repetitive Avalanche Current <sup>7</sup>	20	Amps
$E_{AR}$	Repetitive Avalanche Energy <sup>7</sup>	1	
$E_{AS}$	Single Pulse Avalanche Energy <sup>4</sup>	1800	$\mu\text{J}$

### STATIC ELECTRICAL CHARACTERISTICS

Symbol	Characteristic / Test Conditions	MIN	TYP	MAX	UNIT
$BV_{(DSS)}$	Drain-Source Breakdown Voltage ( $V_{GS} = 0\text{V}$ , $I_D = 500\mu\text{A}$ )	600			Volts
$R_{DS(on)}$	Drain-Source On-State Resistance <sup>2</sup> ( $V_{GS} = 10\text{V}$ , $I_D = 60\text{A}$ )		0.03	0.035	Ohms
$I_{DSS}$	Zero Gate Voltage Drain Current ( $V_{DS} = 600\text{V}$ , $V_{GS} = 0\text{V}$ )		1.0	50	$\mu\text{A}$
	Zero Gate Voltage Drain Current ( $V_{DS} = 600\text{V}$ , $V_{GS} = 0\text{V}$ , $T_c = 150^\circ\text{C}$ )			500	
$I_{GSS}$	Gate-Source Leakage Current ( $V_{GS} = \pm 20\text{V}$ , $V_{DS} = 0\text{V}$ )			$\pm 200$	nA
$V_{GS(th)}$	Gate Threshold Voltage ( $V_{DS} = V_{GS}$ , $I_D = 5.4\text{mA}$ )	2.10	3	3.9	Volts

 CAUTION: These Devices are Sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

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Microsemi Website - <http://www.microsemi.com>

## DYNAMIC CHARACTERISTICS

APT94N60L2C3(G)

Symbol	Characteristic	Test Conditions	MIN	TYP	MAX	UNIT
$C_{iss}$	Input Capacitance	$V_{GS} = 0V$ $V_{DS} = 25V$ $f = 1 MHz$		13600		pF
$C_{oss}$	Output Capacitance			4400		
$C_{rss}$	Reverse Transfer Capacitance			290		
$Q_g$	Total Gate Charge <sup>5</sup>	$V_{GS} = 10V$ $V_{DD} = 300V$ $I_D = 94A @ 25^\circ C$		505	640	nC
$Q_{gs}$	Gate-Source Charge			48		
$Q_{gd}$	Gate-Drain ("Miller") Charge			240		
$t_{d(on)}$	Turn-on Delay Time	<b>INDUCTIVE SWITCHING</b> $V_{GS} = 13V$ $V_{DD} = 380V$ $I_D = 94A @ 125^\circ C$ $R_G = 0.9\Omega$		18		ns
$t_r$	Rise Time			27		
$t_{d(off)}$	Turn-off Delay Time			110	165	
$t_f$	Fall Time			8	12	
$E_{on}$	Turn-on Switching Energy <sup>6</sup>	<b>INDUCTIVE SWITCHING @ 25°C</b> $V_{DD} = 400V, V_{GS} = 15V$ $I_D = 94A, R_G = 5\Omega$		2040		\mu J
$E_{off}$	Turn-off Switching Energy			3515		
$E_{on}$	Turn-on Switching Energy <sup>6</sup>	<b>INDUCTIVE SWITCHING @ 125°C</b> $V_{DD} = 400V, V_{GS} = 15V$ $I_D = 94A, R_G = 5\Omega$		2920		\mu J
$E_{off}$	Turn-off Switching Energy			3970		

## SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

Symbol	Characteristic / Test Conditions	MIN	TYP	MAX	UNIT
$I_S$	Continuous Source Current (Body Diode)			94	Amps
$I_{SM}$	Pulsed Source Current <sup>2</sup> (Body Diode)			282	
$V_{SD}$	Diode Forward Voltage <sup>4</sup> ( $V_{GS} = 0V, I_S = -94A$ )		1	1.2	Volts
$\frac{dv}{dt}$	Peak Diode Recovery $\frac{dv}{dt}$ <sup>7</sup>			6	V/ns
$t_{rr}$	Reverse Recovery Time ( $I_S = -94A, \frac{di}{dt} = 100A/\mu s$ )		861		ns
$Q_{rr}$	Reverse Recovery Charge ( $I_S = -94A, \frac{di}{dt} = 100A/\mu s$ )		46		\mu C

## THERMAL CHARACTERISTICS

Symbol	Characteristic	MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Junction to Case			0.15	°C/W
$R_{\theta JA}$	Junction to Ambient			62	

1 Continuous current limited by package lead temperature.

4 Pulse Test: Pulse width < 380 μs, Duty Cycle < 2%

2 Repetitive Rating: Pulse width limited by maximum junction temperature

5 See MIL-STD-750 Method 3471

3 Repetitive avalanche causes additional power losses that can be calculated as

6 Eon includes diode reverse recovery.

$P_{AV} = E_{AR} * f$ . Pulse width tp limited by  $T_j$  max.

7 Maximum 125°C diode commutation speed =  $di/dt$  600A/μs

Microsemi reserves the right to change, without notice, the specifications and information contained herein.

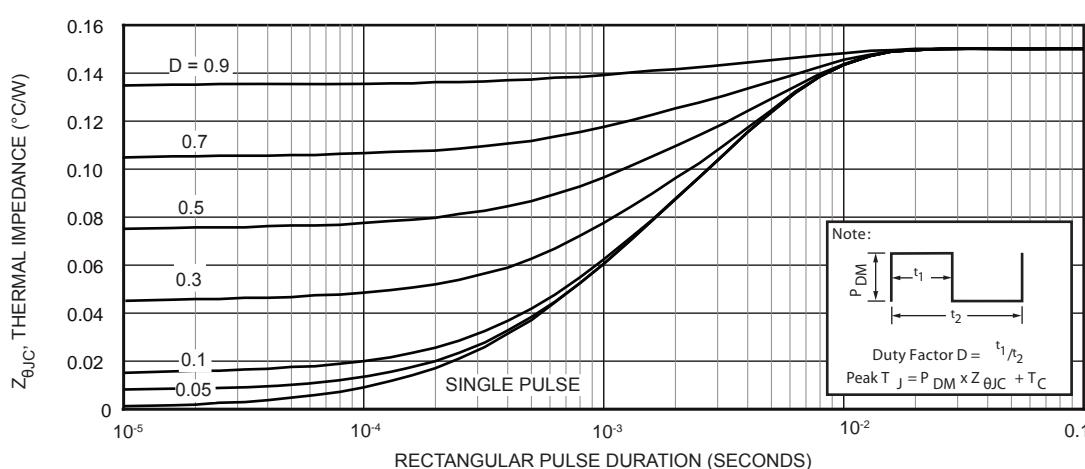
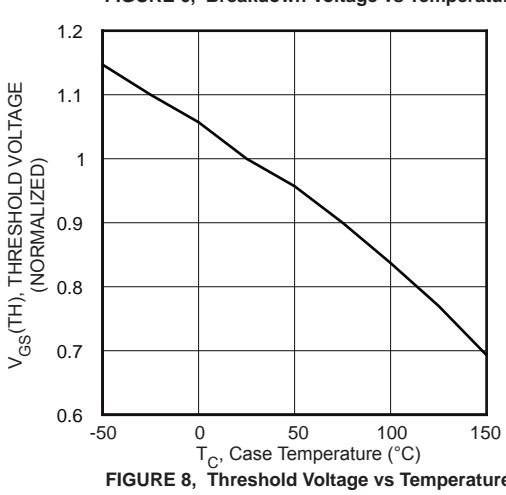
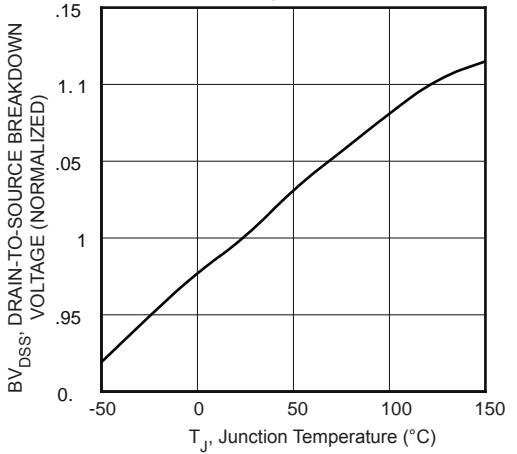
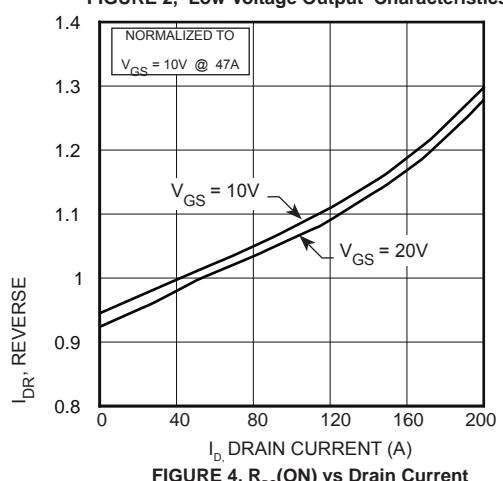
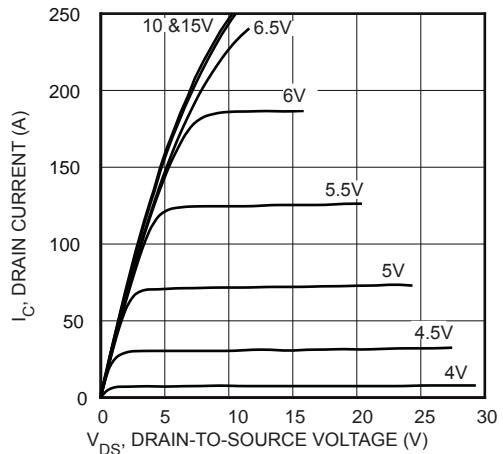
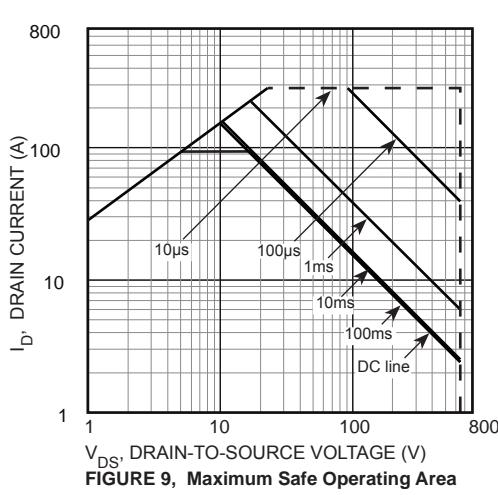
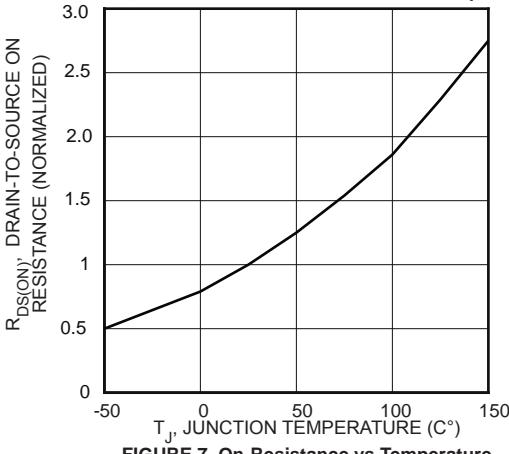
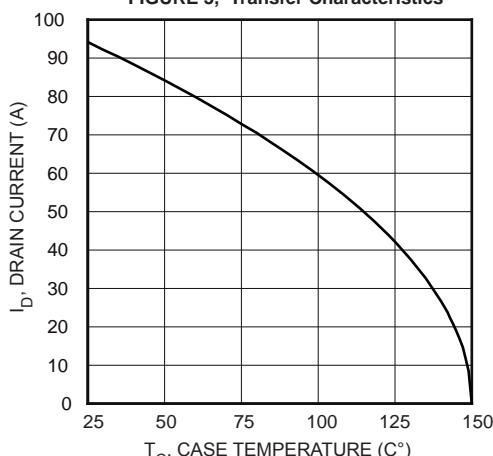
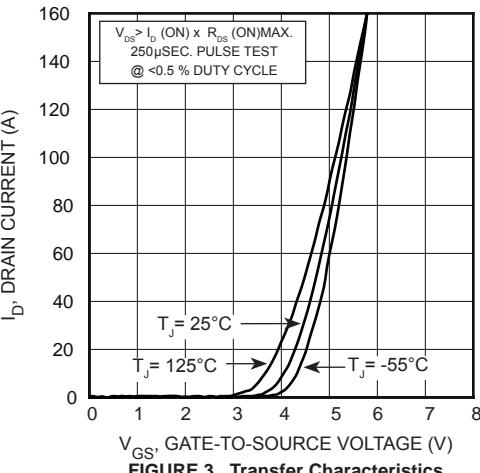


Figure 1, Maximum Effective Transient Thermal Impedance, Junction-To-Case vs Pulse Duration

## Typical Performance Curves



## APT94N60L2C3(G)



## Typical Performance Curves

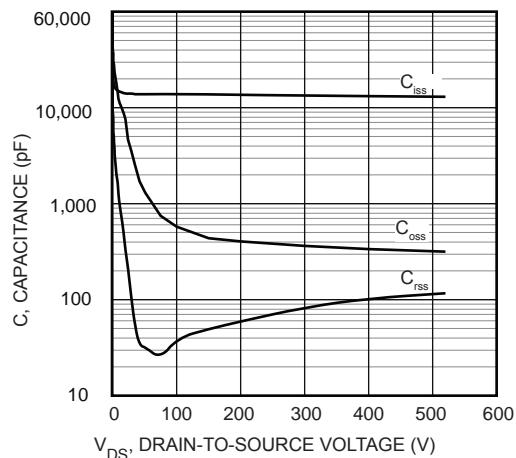


FIGURE 10, Capacitance vs Drain-To-Source Voltage

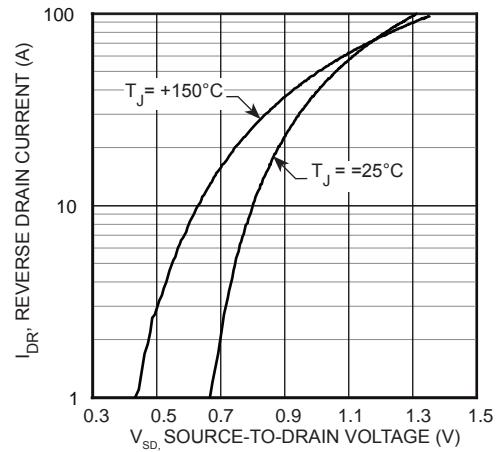


FIGURE 12, Source-Drain Diode Forward Voltage

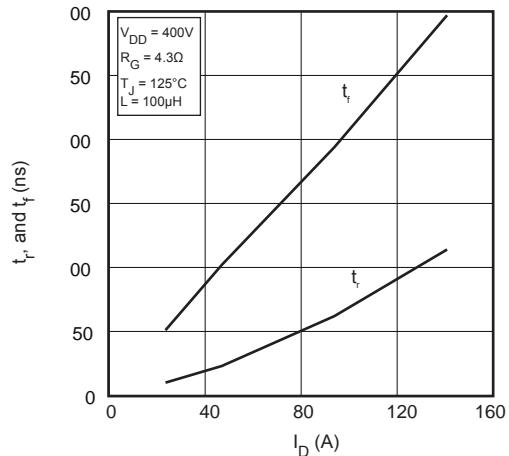


FIGURE 14 , Rise and Fall Times vs Current

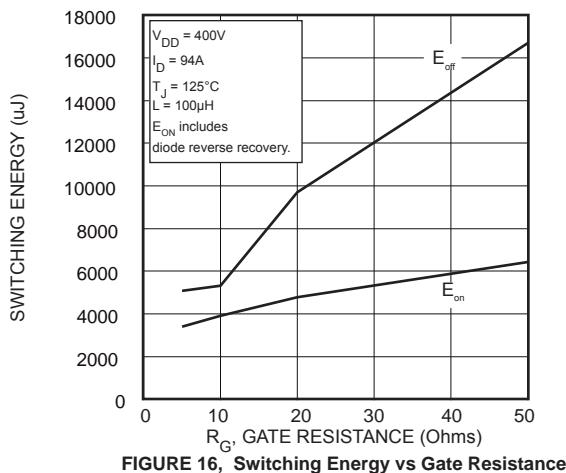


FIGURE 16, Switching Energy vs Gate Resistance

## APT94N60L2C3(G)

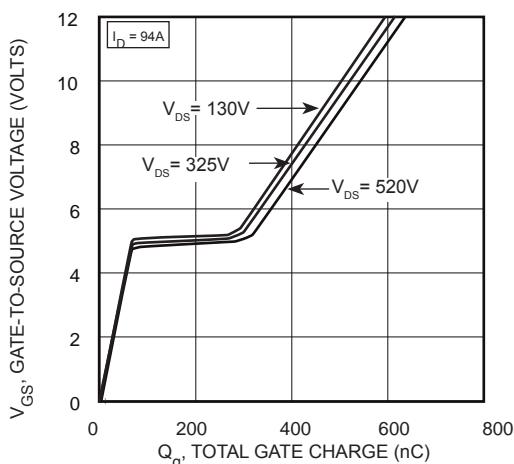


FIGURE 11, Gate Charges vs Gate-To-Source Voltage

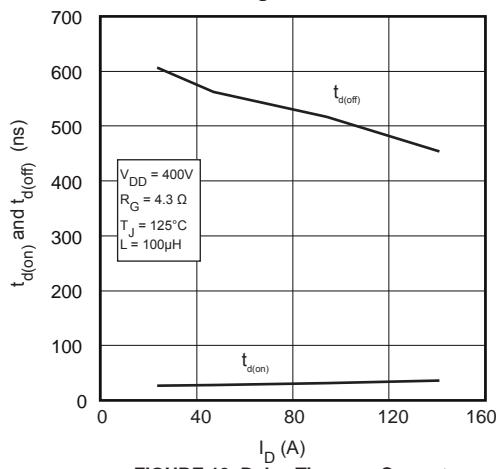


FIGURE 13, Delay Times vs Current

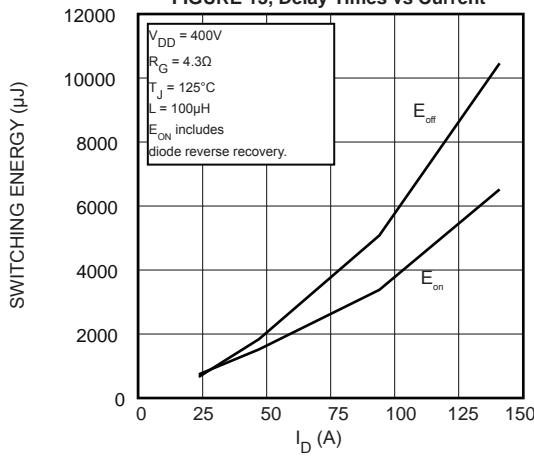


FIGURE 15, Switching Energy vs Current

## Typical Performance Curves

APT94N60L2C3(G)

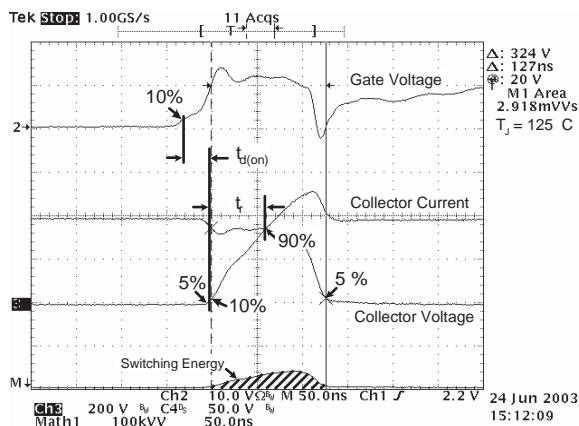


Figure 17, Turn-on Switching Waveforms and Definitions

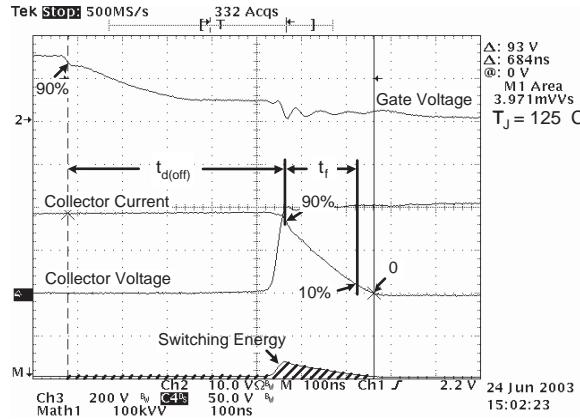


Figure 18, Turn-off Switching Waveforms and Definitions

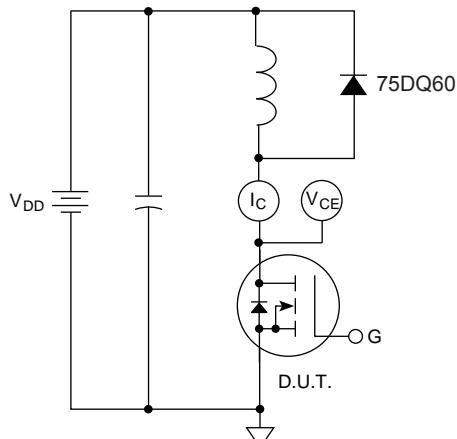


Figure 19, Inductive Switching Test Circuit

## TO-264 (L) Package Outline

(e3)100% Sn Plated

